



Datasheet for part number CIR06AF-28-19PW-F80-T12

Our Catalog Part Number: CIR06AF-28-19PW-F80-T12
Brand: VEAM Product Category: Circular Product Line: Veam CIR, VBN, Other Series: CIR / FRCIR

Product Datasheet	
SERIES	Connector with Bayonet Coupling
Shell Style	Straight Plug Connector
Environmental Class	Backshell with A style clamp and bushing
Shell Size	28
Contact Arrangement	28-19
Total Number of contacts	10 contacts
Number of Contacts Size 12	4 contacts size 12
Number of Contacts Size 16	6 contacts size 16
Insulator Rotation	80°
Gender	Pin
Contact Type	Crimp for AWG wire (used in F80 insert)
Contact Plating	Gold
Shell Material	Aluminium alloy
Shell Plating	Olive drab chromate over cadmium plating (conductive)
Wire Size Cross Section for Contacts Size 12	3 mm <sup>2</sup> or AWG 12
Wire Size Cross Section for Contacts Size 16	1,0-1,5 mm <sup>2</sup> or AWG 18-16
Contact Rating for Contacts Size 12	Maximum Current = 41 A Rated and Test Current = 23 A Potential Drop max. 63 mV
Contact Rating for Contacts Size 16	Maximum Current = 22 A Rated and Test Current = 13 A Potential Drop max. 74 mV
Shock Resistance	Waterproof to 10 meters (33 ft) 12 h (14.7 PSI)
Coupling	2000 couplings minimum
Service Rating Letter	differs by position of contact - consult factory or refer to catalog
Operating Voltage DC	differs by position of contact - consult factory or refer to catalog
Operating Voltage AC	differs by position of contact - consult factory or refer to catalog
Dielectric strength - Minimum Flashover AC RMS	differs by position of contact - consult factory or refer to catalog
Dielectric strength - Test Voltage AC RMS (Hi Pot)	differs by position of contact - consult factory or refer to catalog
Note	Voltages in excess of 30 V ac or 42.5 V dc are potentially hazardous and care should be taken to ensure that such voltages can't be transmitted in any way to exposed metal parts of the connector body.
General	Veam CIR series Connectors are produced in accordance with NATO Standard VG95234, which is based on MIL-C-5015 for physical size, layout and environment requirements.